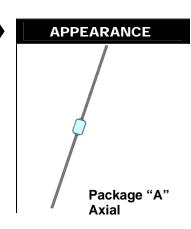


1N6620 thru 1N6625

VOIDLESS-HERMETICALLY SEALED **ULTRA FAST RECOVERY GLASS** RECTIFIERS

DESCRIPTION

This "Ultrafast Recovery" rectifier diode series is military qualified to MIL-PRF-19500/585 and is ideal for high-reliability applications where a failure cannot be tolerated. These industry-recognized 1.5 to 2.0 Amp rated rectifiers for working peak reverse voltages from 200 to 1000 volts are hermetically sealed with voidlessglass construction using an internal "Category I" metallurgical bond. These devices are also available in surface mount MELF package configurations by adding a "US" suffix (see separate data sheet for 1N6620US thru 1N6625US). Microsemi also offers numerous other rectifier products to meet higher and lower current ratings with various recovery time speed requirements including standard, fast and ultrafast device types in both through-hole and surface mount packages.



www.**Microsemi**.cow

IMPORTANT: For the most current data, consult MICROSEMI's website: http://www.microsemi.com

FEATURES

- Popular JEDEC registered 1N6620 to 1N6625 series .
- Voidless hermetically sealed glass package •
- Extremely robust construction ٠
- **Triple-layer** passivation
- Internal "Category I" Metallurgical bonds
- JAN, JANTX, and JANTXV available per MIL-PRF-. 19500/585
- Further options for screening in accordance with . MIL-PRF-19500 for JANS by using a "SP" prefix, e.g. SP6620, SP6624, etc.
- Surface mount equivalents also available in a square end-cap MELF configuration with "US" suffix (see separate data sheet for 1N6620US thru 1N6625US)

MAXIMUM RATINGS

- Junction Temperature: -65°C to +150°C ٠
- Storage Temperature: -65°C to +175°C
- Peak Forward Surge Current @ 25°C: 20 Amps (except 1N6625 which is 15 Amps) Note: Test pulse = 8.3 ms, half-sine wave.
- Average Rectified Forward Current (I₀) at $T_L = +55^{\circ}C$ • (L=.375 inch from body): 1N6620 thru 1N6622: 2.0 Amps 1N6623 thru 1N6625: 1.5 Amps (Derate linearly at 0.833%/°C for T_{L} > +55°C)
- Average Rectified Forward Current (I_O) at T_A=25°C: • 1N6620 thru 1N6622: 1.2 Amps 1N6623 thru 1N6625: 1.0 Amp (Derate linearly at 0.67%/ °C for $T_A>+25$ °C. This I_O rating is typical for PC boards where thermal resistance from mounting point to ambient is sufficiently controlled where $T_{J(max)}$ is not exceeded.)
- Thermal Resistance L= 0.375 inch (R_{BJL}): 38°C/W .
- Capacitance at V_R= 10 V: 10 pF
- Solder temperature: 260°C for 10 s (maximum)

Ultrafast recovery rectifier series 200 to 1000 V

APPLICATIONS / BENEFITS

- Military and other high-reliability applications
- Switching power supplies or other applications requiring extremely fast switching & low forward loss
- High forward surge current capability •
- Low thermal resistance
- Controlled avalanche with peak reverse power capability
- Inherently radiation hard as described in Microsemi MicroNote 050

MECHANICAL AND PACKAGING

- CASE: Hermetically sealed voidless hard glass ٠ with Tunasten slugs
- TERMINATIONS: Axial-leads are Copper with Tin/Lead (Sn/Pb) finish
- MARKING: Body painted and part number, etc.
- POLARITY: Cathode indicated by band
- Tape & Reel option: Standard per EIA-296
- Weight: 340 mg
- See package dimensions on last page



1N6620 thru 1N6625

VOIDLESS-HERMETICALLY SEALED ULTRA FAST RECOVERY GLASS RECTIFIERS

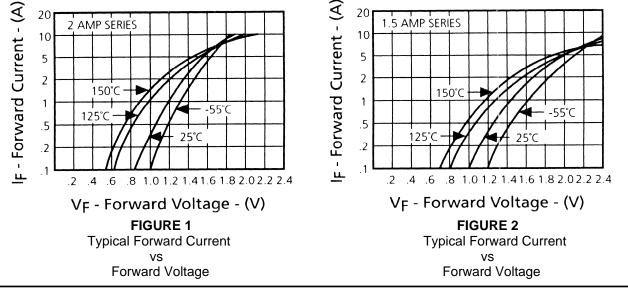
TYPE NUMBER		MAXIMUM FORWARD VOLTAGE V _F @ I _F		WORKING PEAK MAXIMU REVERSE REVERSE VOLTAGE CURRENT V _{RWM} I _R		RSE NT I _R @ MM	MAXIMUM REVERSE RECOVERY TIME (LOW CURRENT)	MAXIMUM REVERSE RECOVERY TIME (HIGH CURRENT)	PEAK RECOVERY CURRENT I_{RM} (rec) $I_F = 2A$,	FORWARD RECOVERY VOLTAGE V _{FRM} Max I _F = 0.5A
	i _R = 50μΑ				T _A =25°C	T _A =150°C	t _{rr} Note 1	t _{rr} Note 2	100A/μs Note 2	t _{fr} =12ns
	v	V @ A	V @ A	v	μA	μA	ns	ns	Α	v
1N6620	220	1.40V @ 1.2A	1.60V @ 2.0A	200	0.5	150	30	45	3.5	12
1N6621	440	1.40V @ 1.2A	1.60V @ 2.0A	400	0.5	150	30	45	3.5	12
1N6622	660	1.40V @ 1.2A	1.60V @ 2.0A	600	0.5	150	30	45	3.5	12
1N6623	880	1.55V @ 1.0A	1.80V @ 1.5A	800	0.5	150	50	60	4.2	18
1N6624	990	1.55V @ 1.0A	1.80V @ 1.5A	900	0.5	150	50	60	4.2	18
1N6625	1100	1.75V @ 1.0A	1.95V @ 1.5A	1000	1.0	200	60	80	5.0	30

Mote 1. Low Current Reverse Recovery Time Test Conditions. $I_F=0.5A$, $I_{RM}=1.0A$, $I_{R(REC)}=0.25A$ per MIL-31D-750 Method 4031, Condition B.

NOTE 2: High Current Reverse Recovery Time Test Conditions: I_F = 2 A, di/dt=100 A/μs MIL-STD-750, Method 4031, Condition D.

SYMBOLS & DEFINITIONS								
Symbol	Symbol Definition							
V _{BR}	Minimum Breakdown Voltage: The minimum voltage the device will exhibit at a specified current.							
V _{RWM}	Working Peak Reverse Voltage: The maximum peak voltage that can be applied over the operating temperature range.							
V _F	Maximum Forward Voltage: The maximum forward voltage the device will exhibit at a specified current.							
I _R	Maximum Reverse Current: The maximum reverse (leakage) current that will flow at the specified voltage and temperature.							
С	Capacitance: The capacitance of the TVS as defined @ 0 volts at a frequency of 1 MHz and stated in picofarads.							
t _{rr}	Reverse Recovery Time: The time interval between the instant the current passes through zero when changing from the forward direction to the reverse direction and a specified recovery decay point after a peak reverse current is reached.							

CHARTS AND GRAPHS



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Microsemi Scottsdale Division

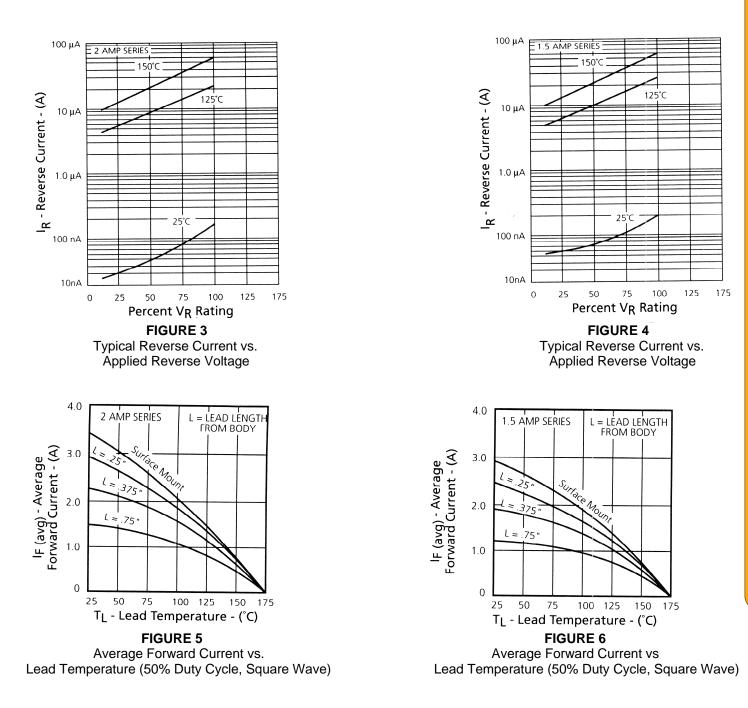
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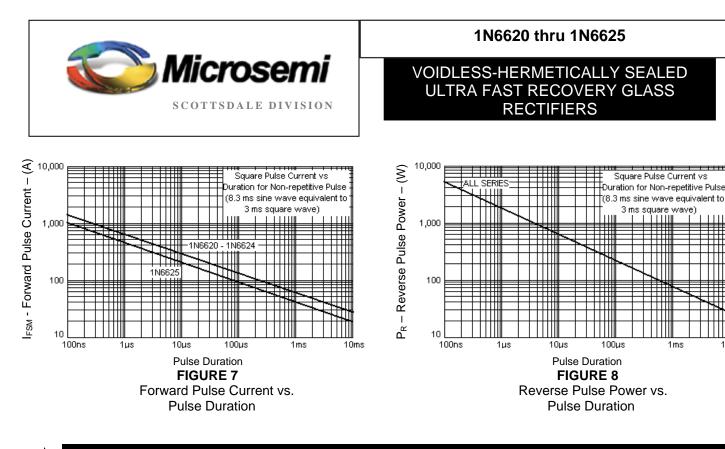
1N6620 thru 1N6625



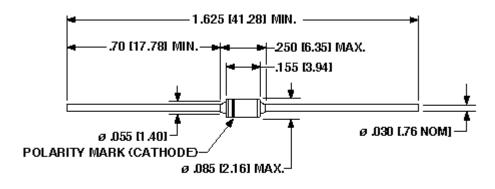
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PACKAGE DIMENSIONS



NOTE: DIMENSIONS IN INCHES [mm]

Lead tolerance = +0.002/-0.003 inches

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10ms